

## 16-Channel, 8-Channel, Differential 8-Channel and Differential 4-Channel, CMOS Analog MUXs with Active Overvoltage Protection

The HI-506A, HI-507A, HI-508A and HI-509A are analog multiplexers with active overvoltage protection. Analog input levels may greatly exceed either power supply without damaging the device or disturbing the signal path of other channels. Active protection circuitry assures that signal fidelity is maintained even under fault conditions that would destroy other multiplexers. Analog inputs can withstand constant 70V<sub>P-P</sub> levels with  $\pm 15V$  supplies. Digital inputs will also sustain continuous faults up to 4V greater than either supply. In addition, signal sources are protected from short circuiting should multiplexer supply loss occur. Each input presents 1k $\Omega$  of resistance under this condition. These features make the HI-506A, HI-507A, HI-508A and HI-509A ideal for use in systems where the analog inputs originate from external equipment, or separately powered circuitry. All devices are fabricated with 44V dielectrically isolated CMOS technology. The HI-506A is a single 16-channel multiplexer, the HI-507A is an 8-channel differential multiplexer, the HI-508A is a single 8-channel multiplexer and the HI-509A is a differential 4-channel multiplexer. If input overvoltage protection is not needed the HI-506/507/508/509 multiplexers are recommended. For further information see Application Notes AN520 and AN521.

## Features

- Analog Overvoltage . . . . . 70V<sub>P-P</sub>
- No Channel Interaction During Overvoltage
- Maximum Power Supply . . . . . 44V
- Fail Safe with Power Loss (No Latch-Up)
- Break-Before-Make Switching
- Analog Signal Range . . . . .  $\pm 15V$
- Access Time . . . . . 500ns
- Power Dissipation . . . . . 7.5mW
- Pb-Free Available (RoHS Compliant)

## Applications

- Data Acquisition Systems
- Industrial Controls
- Telemetry

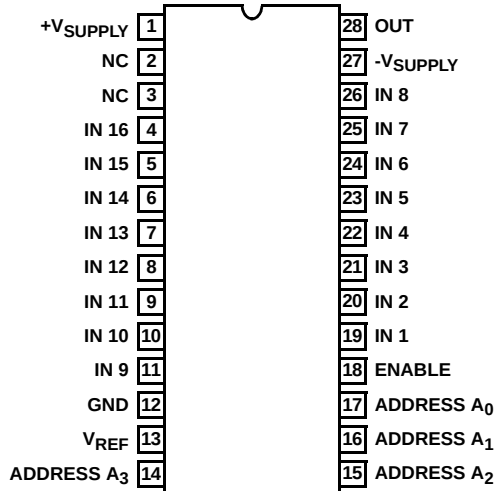
## Ordering Information

| PART NUMBER                | TEMP. RANGE (°C)                 | PACKAGE                 | PKG. DWG. # |
|----------------------------|----------------------------------|-------------------------|-------------|
| HI1-0506A-2                | -55 to 125                       | 28 Ld Cerdip            | F28.6       |
| HI1-0506A-5                | 0 to 75                          | 28 Ld Cerdip            | F28.6       |
| HI1-0506A-8                | -55 to 125<br>+ 160 Hour Burn-In | 28 Ld Cerdip            | F28.6       |
| HI3-0506A-5                | 0 to 75                          | 28 Ld PDIP              | E28.6       |
| HI3-0506A-5Z<br>(See Note) | 0 to 75                          | 28 Ld PDIP<br>(Pb-free) | E28.6       |
| HI3-0507A-5                | 0 to 75                          | 28 Ld PDIP              | E28.6       |
| HI3-0507A-5Z<br>(See Note) | 0 to 75                          | 28 Ld PDIP<br>(Pb-free) | E28.6       |
| HI1-0508A-8                | -55 to 125<br>+ 160 Hour Burn-In | 16 Ld Cerdip            | F16.3       |
| HI3-0508A-5                | +0 to 75                         | 16 Ld PDIP              | E16.3       |
| HI1-0509A-2                | -55 to 125                       | 16 Ld Cerdip            | F16.3       |
| HI1-0509A-5                | 0 to 75                          | 16 Ld Cerdip            | F16.3       |
| HI1-0509A-8                | -55 to 125<br>+ 160 Hour Burn-In | 16 Ld Cerdip            | F16.3       |
| HI3-0509A-5                | 0 to 75                          | 16 Ld PDIP              | E16.3       |
| HI3-0509A-5Z<br>(See Note) | 0 to 75                          | 16 Ld PDIP<br>(Pb-free) | E16.3       |

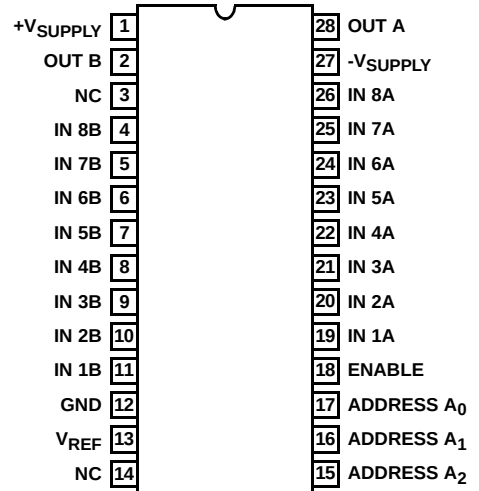
NOTE: Intersil Pb-free products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020C.

## Pinouts

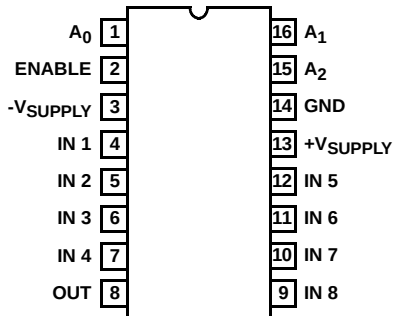
HI-506A (CERDIP, PDIP)  
TOP VIEW



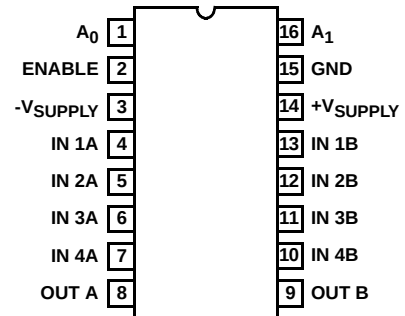
HI-507A (PDIP)  
TOP VIEW



HI-508A (CERDIP, PDIP)  
TOP VIEW



HI-509A (CERDIP, PDIP)  
TOP VIEW



**Truth Tables**

**HI-506A**

| A <sub>3</sub> | A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | “ON” CHANNEL |
|----------------|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | X              | L  | None         |
| L              | L              | L              | L              | H  | 1            |
| L              | L              | L              | H              | H  | 2            |
| L              | L              | H              | L              | H  | 3            |
| L              | L              | H              | H              | H  | 4            |
| L              | H              | L              | L              | H  | 5            |
| L              | H              | L              | H              | H  | 6            |
| L              | H              | H              | L              | H  | 7            |
| L              | H              | H              | H              | H  | 8            |
| H              | L              | L              | L              | H  | 9            |
| H              | L              | L              | H              | H  | 10           |
| H              | L              | H              | L              | H  | 11           |
| H              | L              | H              | H              | H  | 12           |
| H              | H              | L              | L              | H  | 13           |
| H              | H              | L              | H              | H  | 14           |
| H              | H              | H              | L              | H  | 15           |
| H              | H              | H              | H              | H  | 16           |

**HI-508A**

| A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | “ON” CHANNEL |
|----------------|----------------|----------------|----|--------------|
| X              | X              | X              | L  | None         |
| L              | L              | L              | H  | 1            |
| L              | L              | H              | H  | 2            |
| L              | H              | L              | H  | 3            |
| L              | H              | H              | H  | 4            |
| H              | L              | L              | H  | 5            |
| H              | L              | H              | H  | 6            |
| H              | H              | L              | H  | 7            |
| H              | H              | H              | H  | 8            |

**HI-509A**

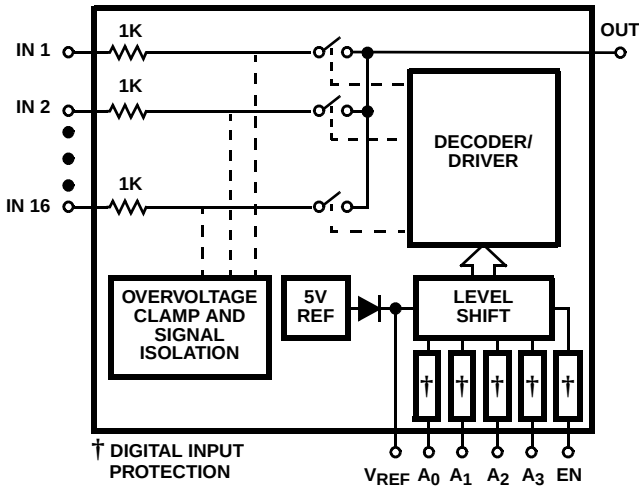
| A <sub>1</sub> | A <sub>0</sub> | EN | “ON” CHANNEL PAIR |
|----------------|----------------|----|-------------------|
| X              | X              | L  | None              |
| L              | L              | H  | 1                 |
| L              | H              | H  | 2                 |
| H              | L              | H  | 3                 |
| H              | H              | H  | 4                 |

**HI-507A**

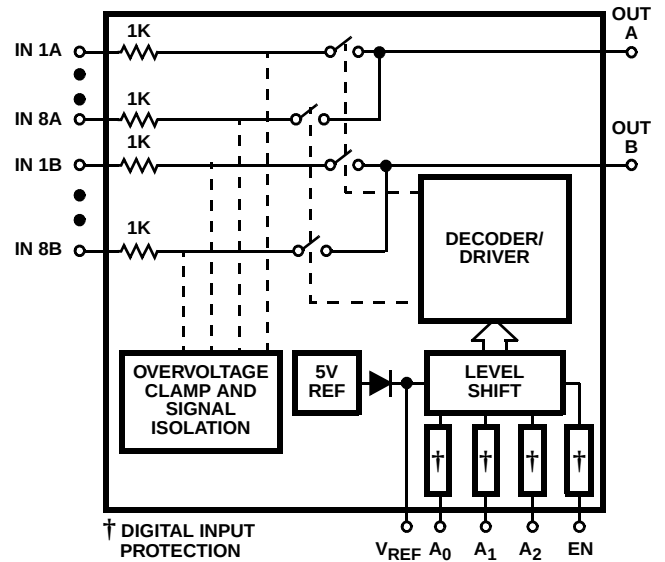
| A <sub>2</sub> | A <sub>1</sub> | A <sub>0</sub> | EN | “ON” CHANNEL PAIR |
|----------------|----------------|----------------|----|-------------------|
| X              | X              | X              | L  | None              |
| L              | L              | L              | H  | 1                 |
| L              | L              | H              | H  | 2                 |
| L              | H              | L              | H  | 3                 |
| L              | H              | H              | H  | 4                 |
| H              | L              | L              | H  | 5                 |
| H              | L              | H              | H  | 6                 |
| H              | H              | L              | H  | 7                 |
| H              | H              | H              | H  | 8                 |

## Functional Diagrams

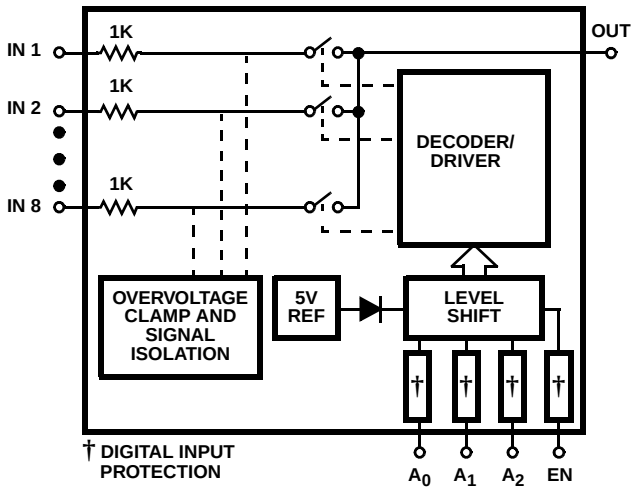
HI-506A



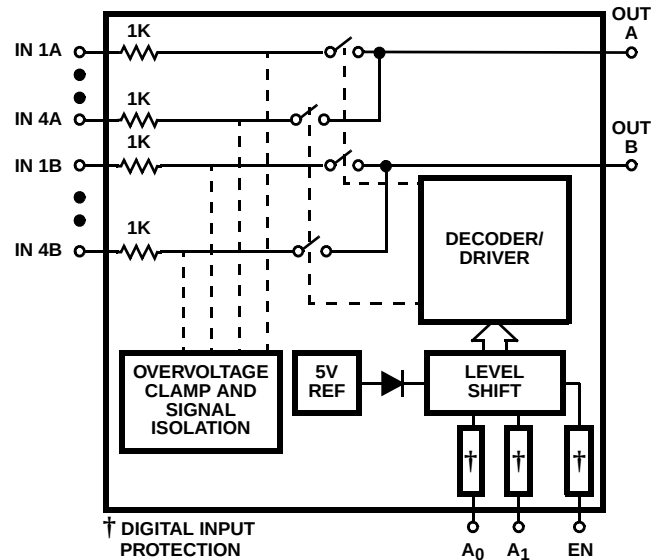
HI-507A



HI-508A

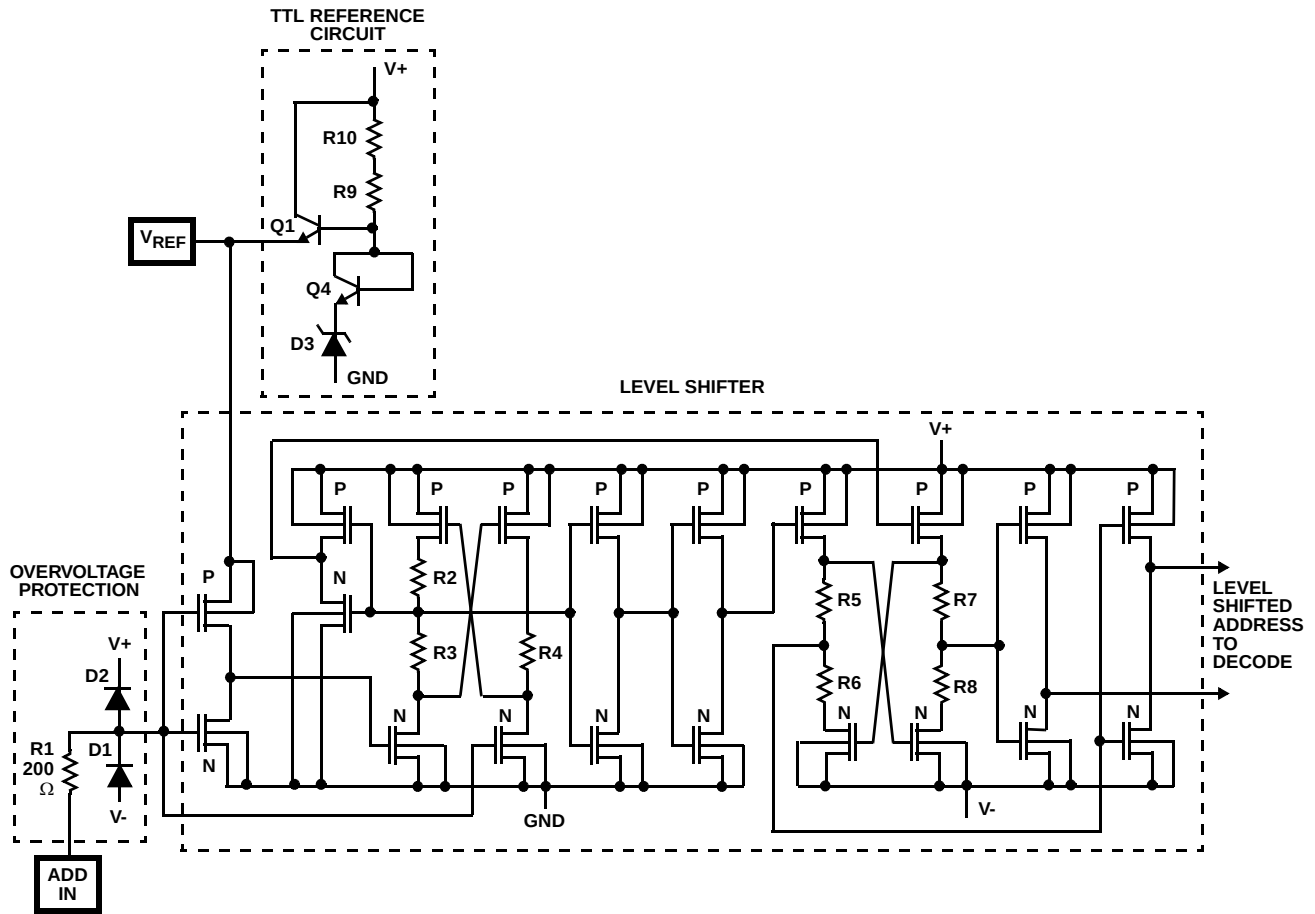


HI-509A

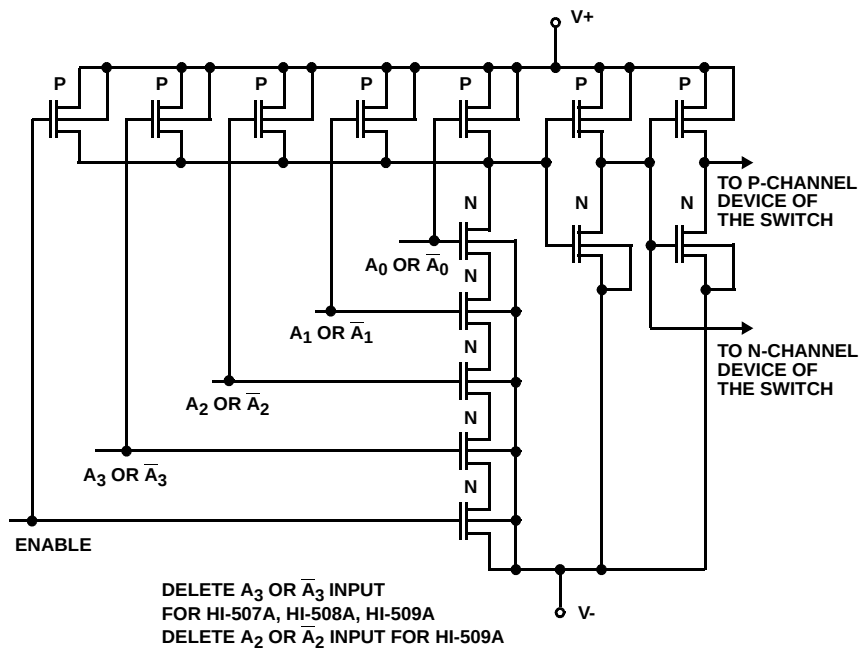


## Schematic Diagrams

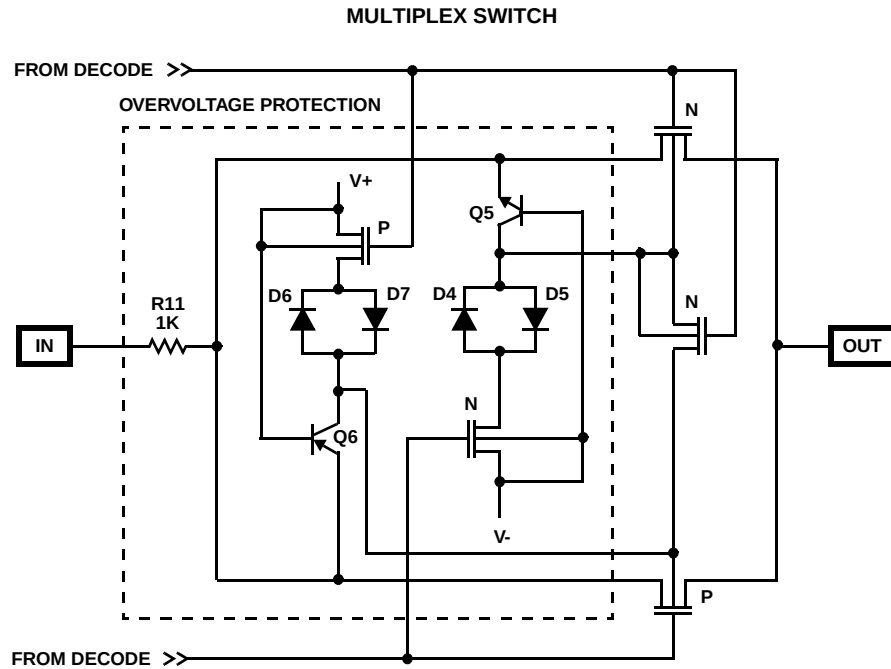
### ADDRESS INPUT BUFFER AND LEVEL SHIFTER



### ADDRESS DECODER



**Schematic Diagrams** (Continued)



# HI-506A, HI-507A, HI-508A, HI-509A

## Absolute Maximum Ratings

|                                                           |                                                         |
|-----------------------------------------------------------|---------------------------------------------------------|
| V+ to V-                                                  | +44V                                                    |
| V+ to GND                                                 | +22V                                                    |
| V- to GND                                                 | -25V                                                    |
| Digital Input Voltage ( $V_{EN}$ , $V_A$ )                | (V-) -4V to (V+) +4V<br>or 20mA, Whichever Occurs First |
| Analog Signal ( $V_{IN}$ , $V_{OUT}$ )                    | (V-) -20V to (V+) +20V                                  |
| Continuous Current, IN or OUT                             | 20mA                                                    |
| Peak Current, IN or OUT, Pulsed 1ms, 10% Duty Cycle (Max) | 40mA                                                    |

## Operating Conditions

### Temperature Ranges

|                              |                |
|------------------------------|----------------|
| HI-506A/507A/508A/509A-2, -8 | -55°C to 125°C |
| HI-506A/507A/508A/509A-5     | 0°C to 75°C    |

## Thermal Information

|                                          |                      |                      |
|------------------------------------------|----------------------|----------------------|
| Thermal Resistance (Typical, Note 1)     | $\theta_{JA}$ (°C/W) | $\theta_{JC}$ (°C/W) |
| 28 Ld CERDIP Package                     | 55                   | 18                   |
| 16 Ld CERDIP Package                     | 75                   | 22                   |
| 28 Ld PDIP Package                       | 60                   | N/A                  |
| 16 Ld PDIP Package                       | 90                   | N/A                  |
| Maximum Junction Temperature             |                      |                      |
| CERDIP Packages                          |                      | 175°C                |
| PDIP Packages                            |                      | 150°C                |
| Maximum Storage Temperature Range        |                      | -65°C to 150°C       |
| Maximum Lead Temperature (Soldering 10s) |                      | 300°C                |

**CAUTION:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### NOTE:

- $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

## Electrical Specifications

Supplies = +15V, -15V;  $V_{REF}$  Pin = Open;  $V_{AH}$  (Logic Level High) = 4V;  $V_{AL}$  (Logic Level Low) = 0.8V, Unless Otherwise Specified. For Test Conditions, Consult Test Circuits Section

| PARAMETER                                            | TEST CONDITIONS | TEMP (°C) | -2, -8 |     |      | -5  |     |      | UNITS |
|------------------------------------------------------|-----------------|-----------|--------|-----|------|-----|-----|------|-------|
|                                                      |                 |           | MIN    | TYP | MAX  | MIN | TYP | MAX  |       |
| DYNAMIC CHARACTERISTICS                              |                 |           |        |     |      |     |     |      |       |
| Access Time, t <sub>A</sub>                          | Note 2          | 25        | -      | 0.5 | -    | -   | 0.5 | -    | μs    |
|                                                      |                 | Full      | -      | -   | 1.0  | -   | -   | 1.0  | μs    |
| Break-Before-Make Delay, t <sub>OPEN</sub>           | Note 2          | 25        | 25     | 80  | -    | 25  | 80  | -    | ns    |
| Enable Delay (ON), t <sub>ON(EN)</sub>               | Note 2          | 25        | -      | 300 | 500  | -   | 300 | -    | ns    |
|                                                      |                 | Full      | -      | -   | 1000 | -   | -   | 1000 | ns    |
| Enable Delay (OFF), t <sub>OFF(EN)</sub>             | Note 2          | 25        | -      | 300 | 500  | -   | 300 | -    | ns    |
|                                                      |                 | Full      | -      | -   | 1000 | -   | -   | 1000 | ns    |
| Settling Time, t <sub>S</sub><br>HI-506A and HI-507A | To 0.1%         | 25        | -      | 1.2 | -    | -   | 1.2 | -    | μs    |
|                                                      | To 0.01%        | 25        | -      | 3.5 | -    | -   | 3.5 | -    | μs    |
| HI-508A and HI-509A                                  | To 0.1%         | 25        | -      | 1.2 | -    | -   | 1.2 | -    | μs    |
|                                                      | To 0.01%        | 25        | -      | 3.5 | -    | -   | 3.5 | -    | μs    |
| Off Isolation                                        | Note 7          | 25        | 50     | 68  | -    | 50  | 68  | -    | dB    |
| Channel Input Capacitance, C <sub>S(OFF)</sub>       |                 | 25        | -      | 10  | -    | -   | 10  | -    | pF    |
| Channel Output Capacitance, C <sub>D(OFF)</sub>      |                 |           |        |     |      |     |     |      |       |
| HI-506A                                              |                 | 25        | -      | 52  | -    | -   | 52  | -    | pF    |
| HI-507A                                              |                 | 25        | -      | 30  | -    | -   | 30  | -    | pF    |
| HI-508A                                              |                 | 25        | -      | 25  | -    | -   | 25  | -    | pF    |
| HI-509A                                              |                 | 25        | -      | 12  | -    | -   | 12  | -    | pF    |
| Digital Input Capacitance, C <sub>A</sub>            |                 | 25        | -      | 10  | -    | -   | 10  | -    | pF    |
| Input to Output Capacitance, C <sub>DS(OFF)</sub>    |                 | 25        | -      | 0.1 | -    | -   | 0.1 | -    | pF    |
| DIGITAL INPUT CHARACTERISTICS                        |                 |           |        |     |      |     |     |      |       |
| Input Low Threshold, TTL Drive, V <sub>AL</sub>      | Note 2          | Full      | -      | -   | 0.8  | -   | -   | 0.8  | V     |
| Input High Threshold, V <sub>AH</sub> (Note 9)       | Note 2          | Full      | 4.0    | -   | -    | 4.0 | -   | -    | V     |
| Input Leakage Current (High or Low), I <sub>A</sub>  | Notes 2, 6      | Full      | -      | -   | 1.0  | -   | -   | 1.0  | μA    |

# HI-506A, HI-507A, HI-508A, HI-509A

**Electrical Specifications** Supplies = +15V, -15V;  $V_{REF}$  Pin = Open;  $V_{AH}$  (Logic Level High) = 4V;  $V_{AL}$  (Logic Level Low) = 0.8V, Unless Otherwise Specified. For Test Conditions, Consult Test Circuits Section **(Continued)**

| PARAMETER                                                                            | TEST CONDITIONS  | TEMP (°C) | -2, -8 |      |     | -5  |      |     | UNITS      |
|--------------------------------------------------------------------------------------|------------------|-----------|--------|------|-----|-----|------|-----|------------|
|                                                                                      |                  |           | MIN    | TYP  | MAX | MIN | TYP  | MAX |            |
| MOS Drive, $V_{AL}$ , HI-506A/HI-507A                                                | $V_{REF} = +10V$ | 25        | -      | -    | 0.8 | -   | -    | 0.8 | V          |
| MOS Drive, $V_{AH}$ , HI-506A/HI-507A                                                | $V_{REF} = +10V$ | 25        | 6.0    | -    | -   | 6.0 | -    | -   | V          |
| <b>ANALOG CHANNEL CHARACTERISTICS</b>                                                |                  |           |        |      |     |     |      |     |            |
| Analog Signal Range, $V_{IN}$                                                        | Note 2           | Full      | -15    | -    | +15 | -15 | -    | +15 | V          |
| On Resistance, $r_{ON}$                                                              | Notes 2, 3       | 25        | -      | 1.2  | 1.5 | -   | 1.5  | 1.8 | k $\Omega$ |
|                                                                                      |                  | Full      | -      | 1.5  | 1.8 | -   | 1.8  | 2.0 | k $\Omega$ |
| Off Input Leakage Current, $I_{S(OFF)}$                                              | Notes 2, 4       | 25        | -      | 0.03 | -   | -   | 0.03 | -   | nA         |
|                                                                                      |                  | Full      | -      | -    | 50  | -   | -    | 50  | nA         |
| Off Output Leakage Current, $I_{D(OFF)}$<br>HI-506A<br>HI-507A<br>HI-508A<br>HI-509A | Notes 2, 4       | 25        | -      | 0.1  | -   | -   | 0.1  | -   | nA         |
|                                                                                      |                  | Full      | -      | -    | 300 | -   | -    | 300 | nA         |
|                                                                                      |                  | Full      | -      | -    | 200 | -   | -    | 200 | nA         |
|                                                                                      |                  | Full      | -      | -    | 200 | -   | -    | 200 | nA         |
|                                                                                      |                  | Full      | -      | -    | 100 | -   | -    | 100 | nA         |
| $I_{D(OFF)}$ With Input Overvoltage Applied                                          | Note 5           | 25        | -      | 4.0  | -   | -   | 4.0  | -   | nA         |
|                                                                                      |                  | Full      | -      | -    | 2.0 | -   | -    | -   | $\mu$ A    |
| On Channel Leakage Current, $I_{D(ON)}$<br>HI-506A<br>HI-507A<br>HI-508A<br>HI-509A  | Notes 2, 4       | 25        | -      | 0.1  | -   | -   | 0.1  | -   | nA         |
|                                                                                      |                  | Full      | -      | -    | 300 | -   | -    | 300 | nA         |
|                                                                                      |                  | Full      | -      | -    | 200 | -   | -    | 200 | nA         |
|                                                                                      |                  | Full      | -      | -    | 200 | -   | -    | 200 | nA         |
|                                                                                      |                  | Full      | -      | -    | 100 | -   | -    | 100 | nA         |
| Differential Off Output Leakage Current, $I_{DIFF}$ , (HI-507A, HI-509A Only)        |                  | Full      | -      | -    | 50  | -   | -    | 50  | nA         |
| <b>POWER SUPPLY CHARACTERISTICS</b>                                                  |                  |           |        |      |     |     |      |     |            |
| Current, $I_+$                                                                       | Notes 2, 8       | Full      | -      | 0.5  | 2.0 | -   | 0.5  | 2.0 | mA         |
| Current, $I_-$                                                                       | Notes 2, 8       | Full      | -      | 0.02 | 1.0 | -   | 0.02 | 1.0 | mA         |
| Power Dissipation, $P_D$                                                             |                  | Full      | -      | 7.5  | -   | -   | 7.5  | -   | mW         |

## NOTES:

- 100% tested for Dash 8. Leakage currents not tested at -55°C.
- $V_{OUT} = \pm 10V$ ,  $I_{OUT} = \pm 100\mu A$ .
- 10nA is the practical lower limit for high speed measurement in the production test environment.
- Analog Overvoltage =  $\pm 33V$ .
- Digital input leakage is primarily due to the clamp diodes (see Schematic). Typical leakage is less than 1nA at 25°C.
- $V_{EN} = 0.8V$ ,  $R_L = 1K$ ,  $C_L = 15pF$ ,  $V_S = 7V_{RMS}$ ,  $f = 100kHz$ .
- $V_{EN}$ ,  $V_A = 0V$  or 4V.
- To drive from DTL/TTL Circuits, 1k $\Omega$  pull-up resistors to +5V supply are recommended.



## Test Circuits and Waveforms

$T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ ,  $V_{\text{REF}} = \text{Open}$ ,  
Unless Otherwise Specified

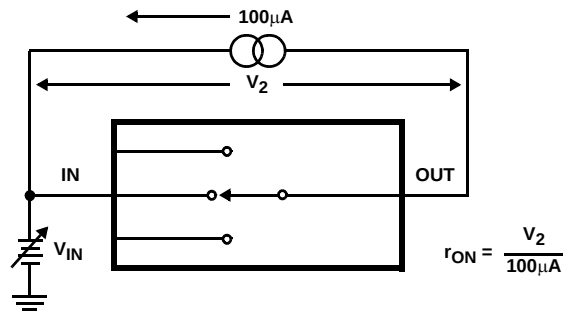


FIGURE 1A. TEST CIRCUIT

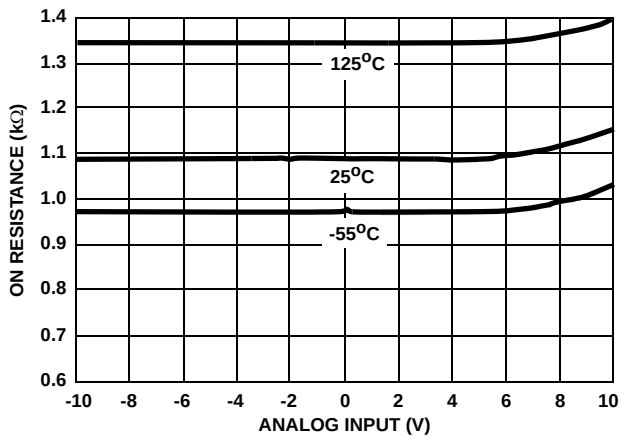


FIGURE 1B. ON RESISTANCE vs ANALOG INPUT VOLTAGE

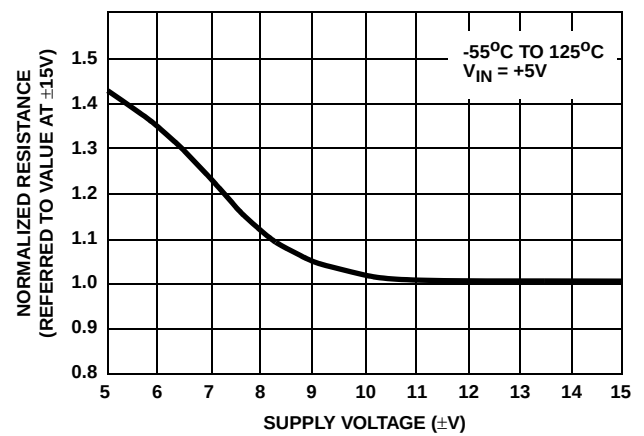


FIGURE 1C. NORMALIZED ON RESISTANCE vs SUPPLY VOLTAGE

FIGURE 1. ON RESISTANCE

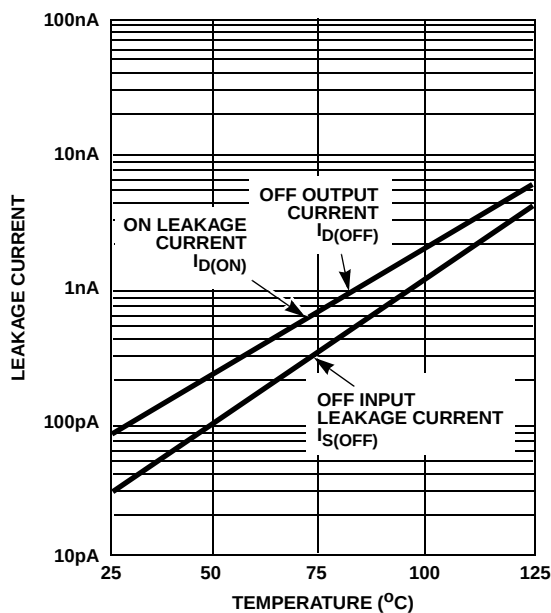


FIGURE 2A. LEAKAGE CURRENT vs TEMPERATURE

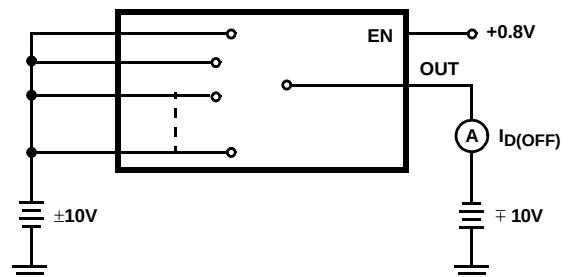


FIGURE 2B.  $I_{\text{D(OFF)}}$  TEST CIRCUIT (NOTE 10)

## Test Circuits and Waveforms

$T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ ,  $V_{\text{REF}} = \text{Open}$ ,  
Unless Otherwise Specified (Continued)

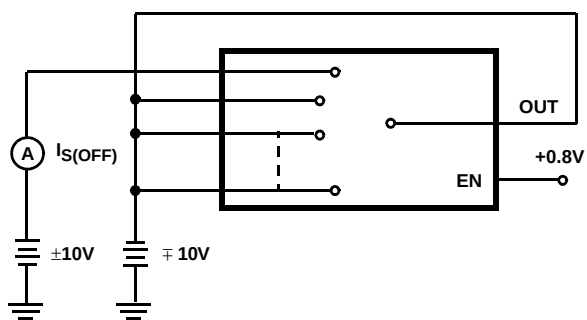


FIGURE 2C.  $I_{\text{S(OFF)}}$  TEST CIRCUIT (NOTE 10)

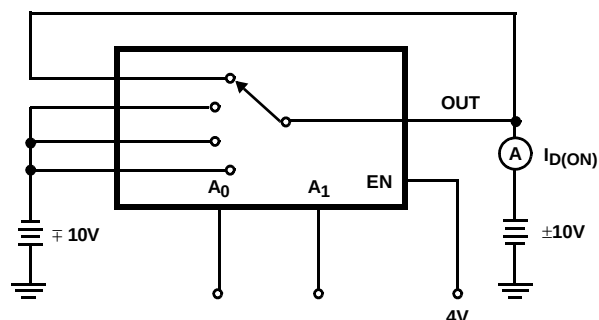


FIGURE 2D.  $I_{\text{D(ON)}}$  TEST CIRCUIT (NOTE 10)

NOTE:

10. Two measurements per channel:  $\pm 10\text{V}$  and  $\mp 10\text{V}$ . (Two measurements per device for  $I_{\text{D(OFF)}}$   $\pm 10\text{V}$  and  $\mp 10\text{V}$ .)

FIGURE 2. LEAKAGE CURRENTS

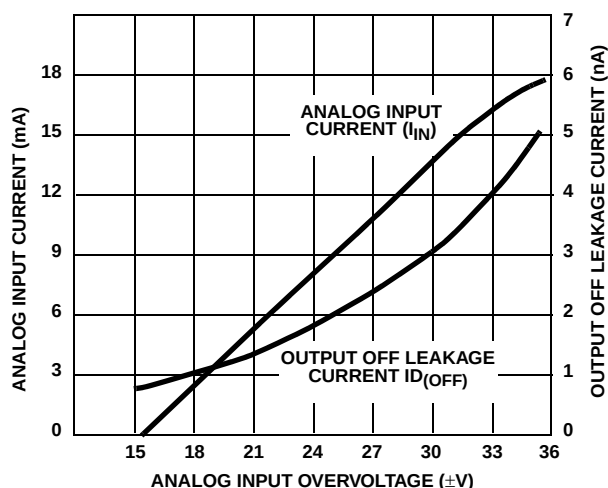


FIGURE 3A. ANALOG INPUT OVERVOLTAGE CHARACTERISTICS

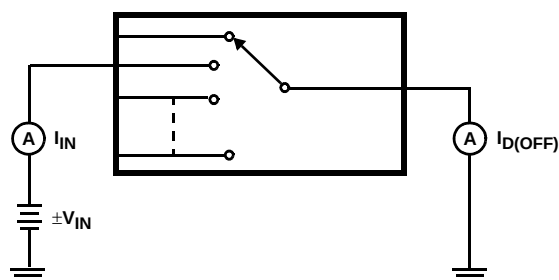


FIGURE 3B. TEST CIRCUIT

FIGURE 3. ANALOG INPUT OVERVOLTAGE CHARACTERISTICS

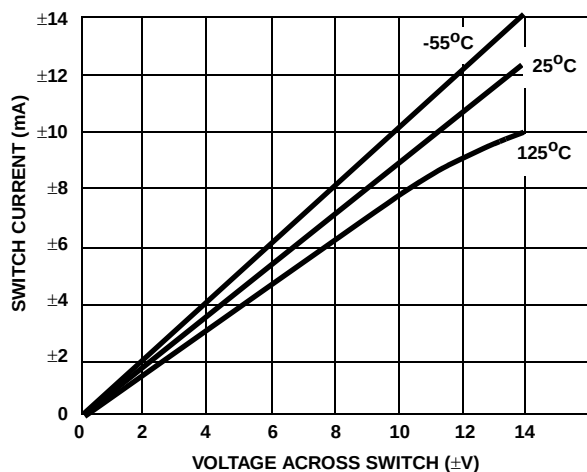


FIGURE 4A. ON CHANNEL CURRENT vs VOLTAGE

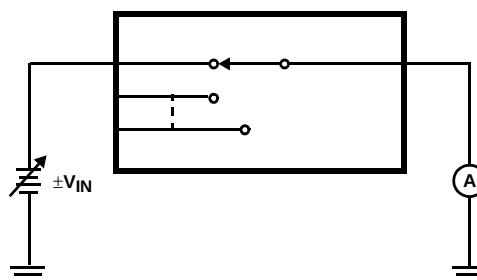


FIGURE 4B. TEST CIRCUIT

FIGURE 4. ON CHANNEL CURRENT

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ ,  $V_{\text{REF}} = \text{Open}$ ,  
Unless Otherwise Specified (Continued)

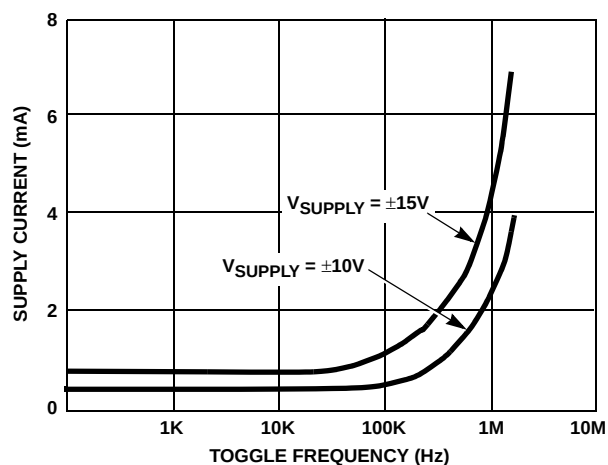
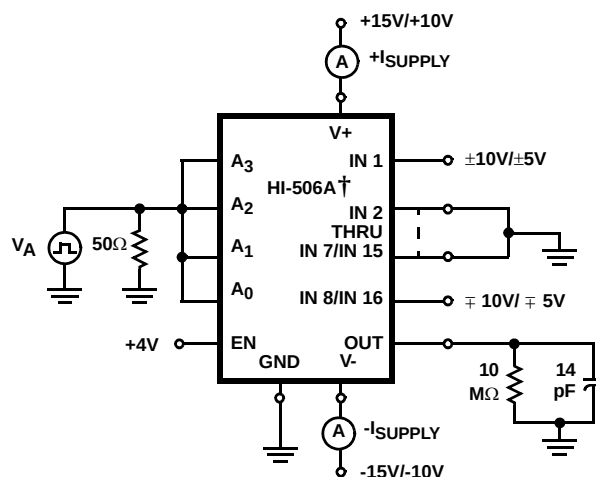


FIGURE 5A. SUPPLY CURRENT vs TOGGLE FREQUENCY



† Similar connection for HI-507A/HI-508A/HI-509A

FIGURE 5B. TEST CIRCUIT

FIGURE 5. DYNAMIC SUPPLY CURRENT

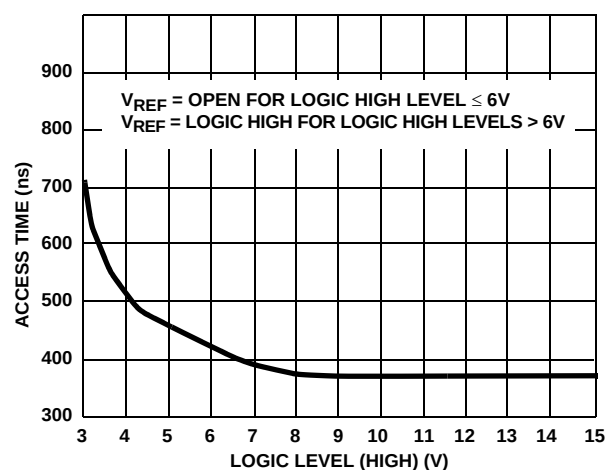
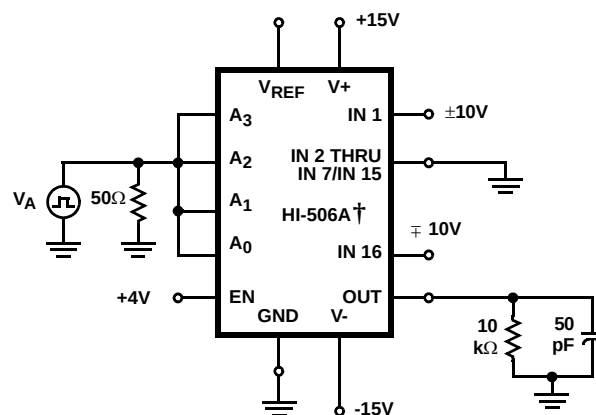


FIGURE 6A. ACCESS TIME vs LOGIC LEVEL (HIGH)



† Similar connection for HI-507A/HI-508A/HI-509A

FIGURE 6B. TEST CIRCUIT

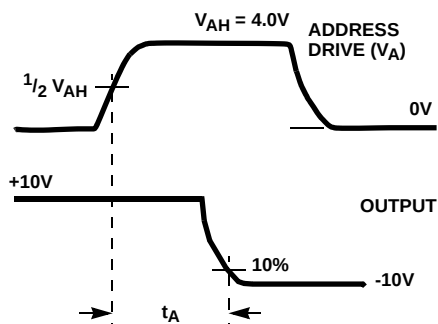


FIGURE 6C. MEASUREMENT POINTS

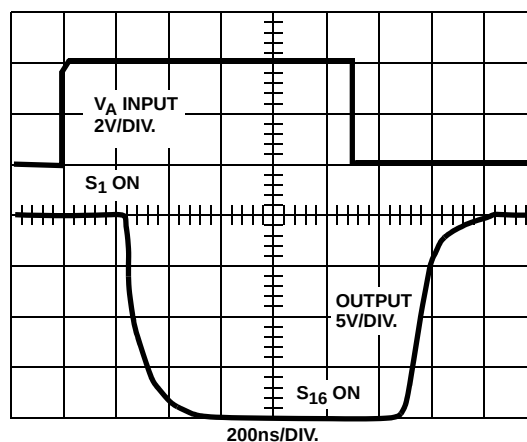
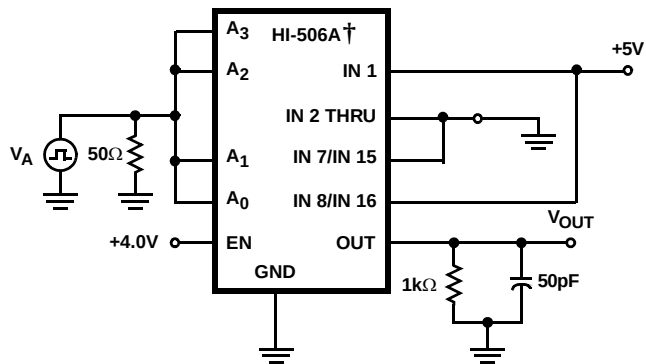


FIGURE 6D. WAVEFORMS

FIGURE 6. ACCESS TIME

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ ,  $V_{\text{REF}} = \text{Open}$ ,  
Unless Otherwise Specified **(Continued)**



† Similar connection for HI-507A/HI-508A/HI-509A

FIGURE 7A. TEST CIRCUIT

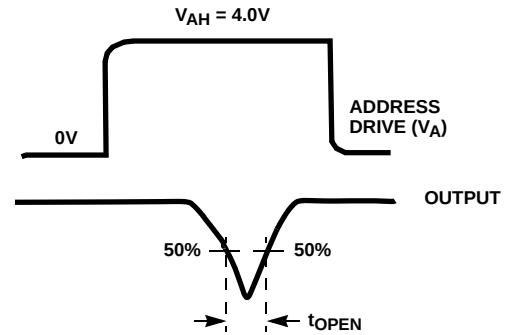


FIGURE 7B. MEASUREMENT POINTS

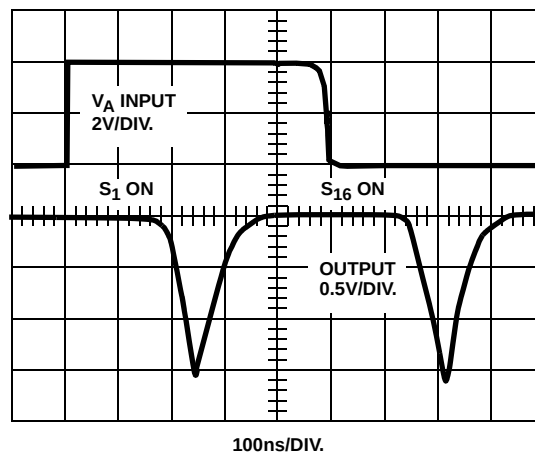
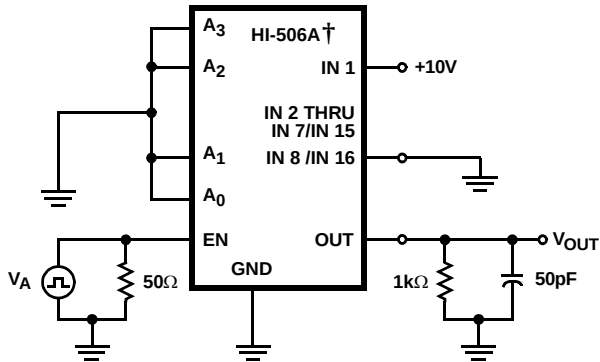


FIGURE 7C. WAVEFORMS

FIGURE 7. BREAK-BEFORE-MAKE DELAY

**Test Circuits and Waveforms**  $T_A = 25^\circ\text{C}$ ,  $V_{\text{SUPPLY}} = \pm 15\text{V}$ ,  $V_{\text{AH}} = 4\text{V}$ ,  $V_{\text{AL}} = 0.8\text{V}$ ,  $V_{\text{REF}} = \text{Open}$ ,  
Unless Otherwise Specified **(Continued)**



† Similar connection for HI-507A/HI-508A/HI-509A

FIGURE 8A. TEST CIRCUIT

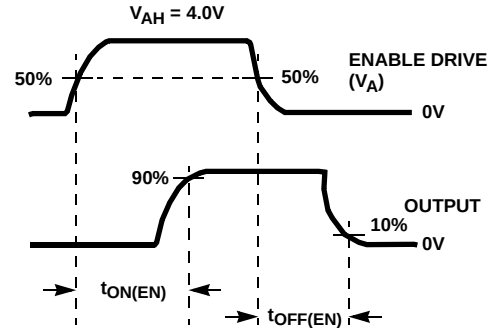


FIGURE 8B. MEASUREMENT POINTS

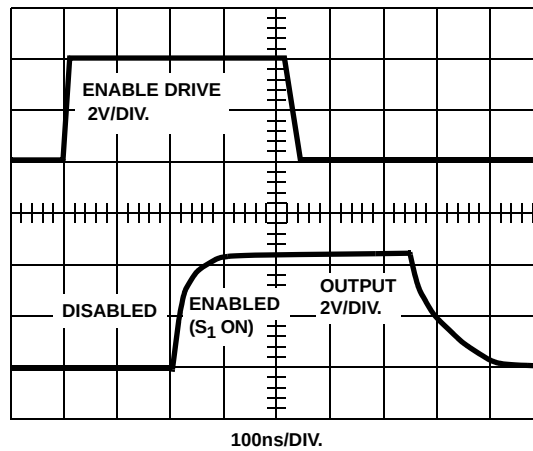


FIGURE 8C. WAVEFORMS

FIGURE 8. ENABLE DELAYS

## Die Characteristics

### DIE DIMENSIONS:

159 mils x 83.9 mils

### METALLIZATION:

Type: CuAl

Thickness:  $16\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

### SUBSTRATE POTENTIAL (NOTE):

$-V_{\text{SUPPLY}}$

### PASSIVATION:

Silox:  $12\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

Nitride:  $3.5\text{k}\text{\AA} \pm 1\text{k}\text{\AA}$

### WORST CASE CURRENT DENSITY:

$1.4 \times 10^5 \text{ A/cm}^2$

### TRANSISTOR COUNT:

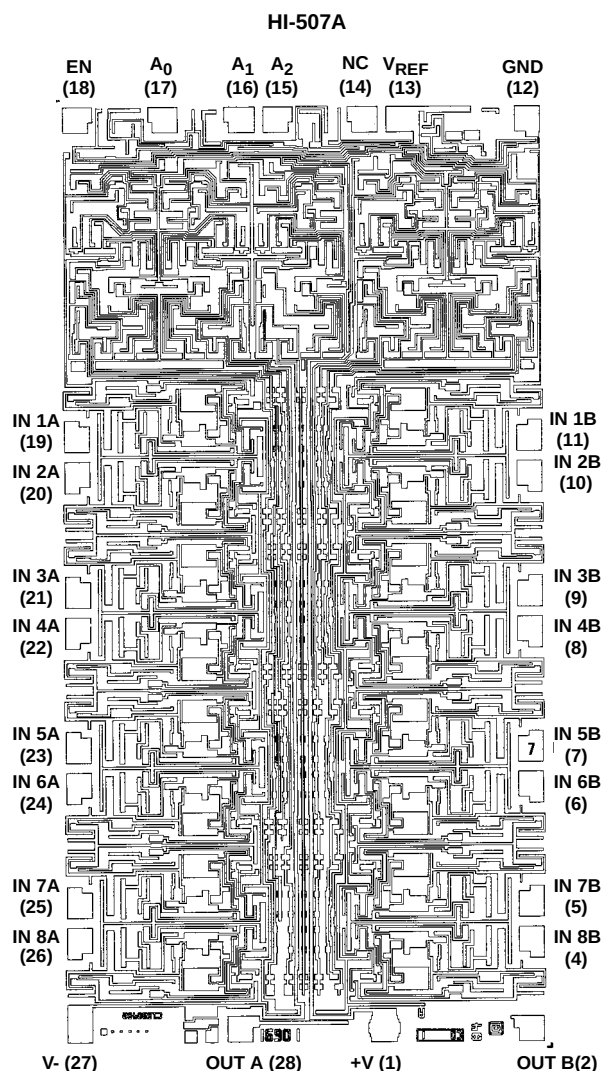
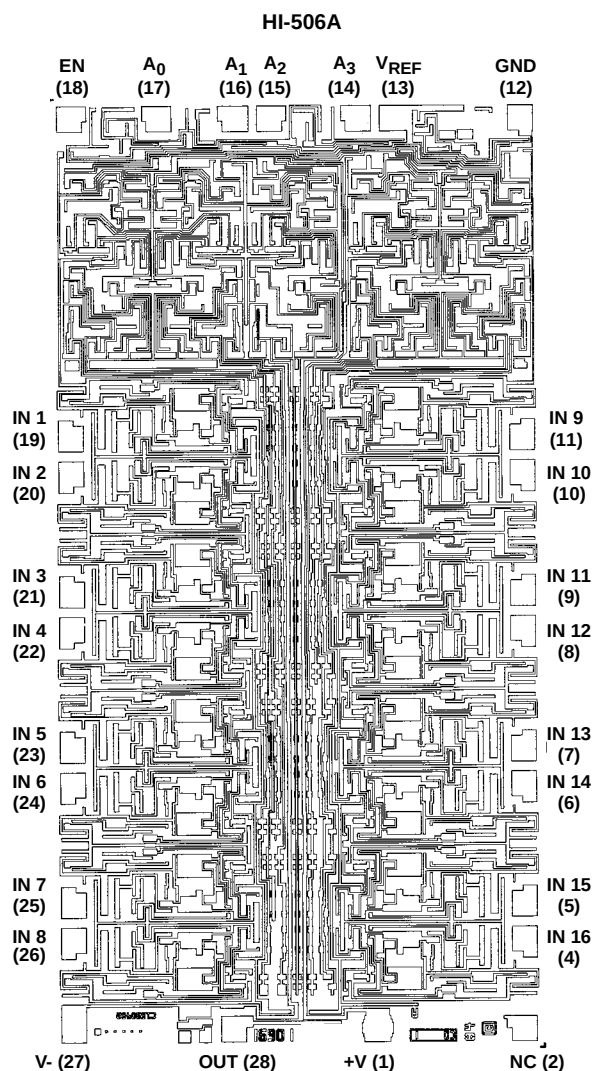
485

### PROCESS:

CMOS-DI

NOTE: The substrate appears resistive to the  $-V_{\text{SUPPLY}}$  terminal, therefore it may be left floating (Insulating Die Mount) or it may be mounted on a conductor at  $-V_{\text{SUPPLY}}$  potential.

## Metallization Mask Layouts



## Die Characteristics

### DIE DIMENSIONS:

108 mils x 83 mils

### METALLIZATION:

Type: CuAl

Thickness:  $16\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

### SUBSTRATE POTENTIAL (NOTE):

$-V_{\text{SUPPLY}}$

### PASSIVATION:

Silox:  $12\text{k}\text{\AA} \pm 2\text{k}\text{\AA}$

Nitride:  $3.5\text{k}\text{\AA} \pm 1\text{k}\text{\AA}$

### WORST CASE CURRENT DENSITY:

$1.4 \times 10^5 \text{ A/cm}^2$

### TRANSISTOR COUNT:

253

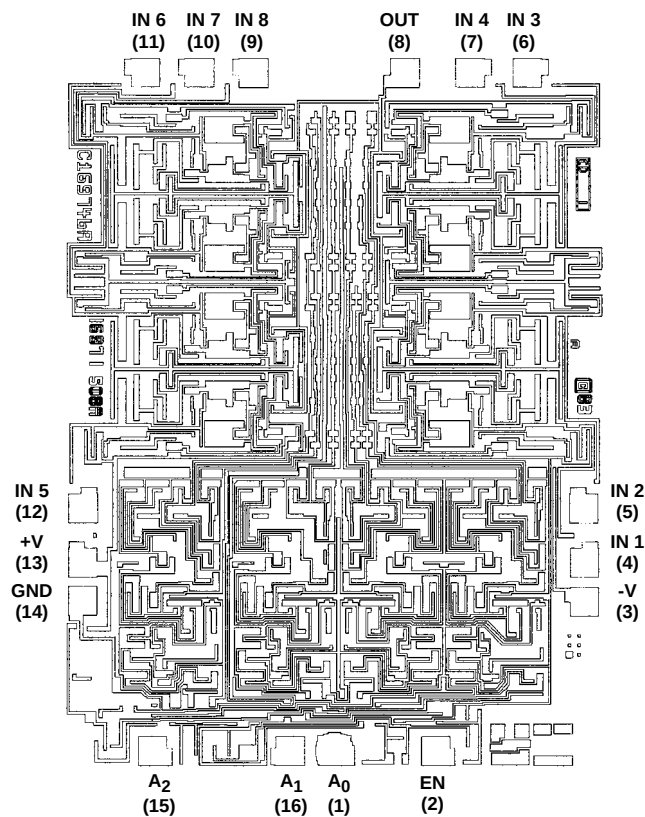
### PROCESS:

CMOS-DI

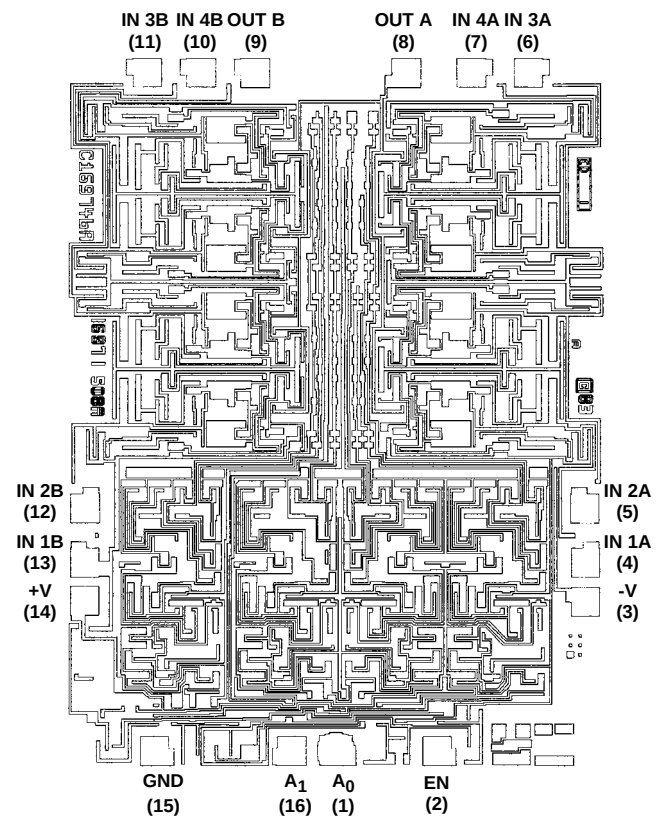
NOTE: The substrate appears resistive to the  $-V_{\text{SUPPLY}}$  terminal, therefore it may be left floating (Insulating Die Mount) or it may be mounted on a conductor at  $-V_{\text{SUPPLY}}$  potential.

## Metallization Mask Layouts

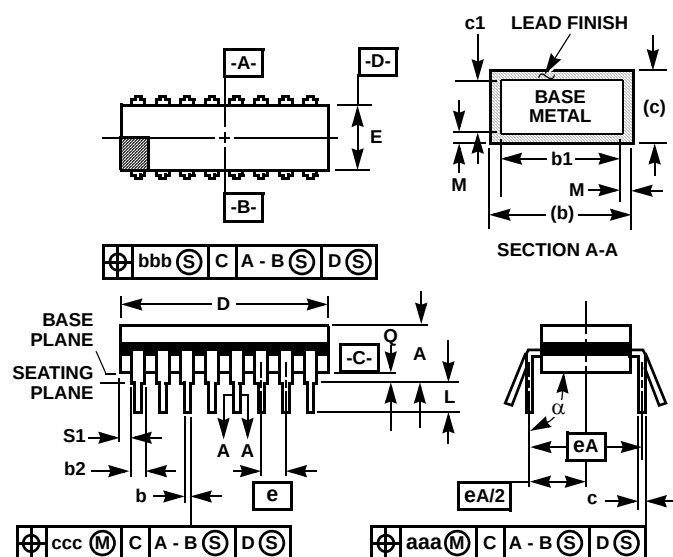
HI-508A



HI-509A



# Ceramic Dual-In-Line Frit Seal Packages (CERDIP)



## NOTES:

1. Index area: A notch or a pin one identification mark shall be located adjacent to pin one and shall be located within the shaded area shown. The manufacturer's identification shall not be used as a pin one identification mark.
2. The maximum limits of lead dimensions b and c or M shall be measured at the centroid of the finished lead surfaces, when solder dip or tin plate lead finish is applied.
3. Dimensions b1 and c1 apply to lead base metal only. Dimension M applies to lead plating and finish thickness.
4. Corner leads (1, N, N/2, and N/2+1) may be configured with a partial lead paddle. For this configuration dimension b3 replaces dimension b2.
5. This dimension allows for off-center lid, meniscus, and glass overrun.
6. Dimension Q shall be measured from the seating plane to the base plane.
7. Measure dimension S1 at all four corners.
8. N is the maximum number of terminal positions.
9. Dimensioning and tolerancing per ANSI Y14.5M - 1982.
10. Controlling dimension: INCH.

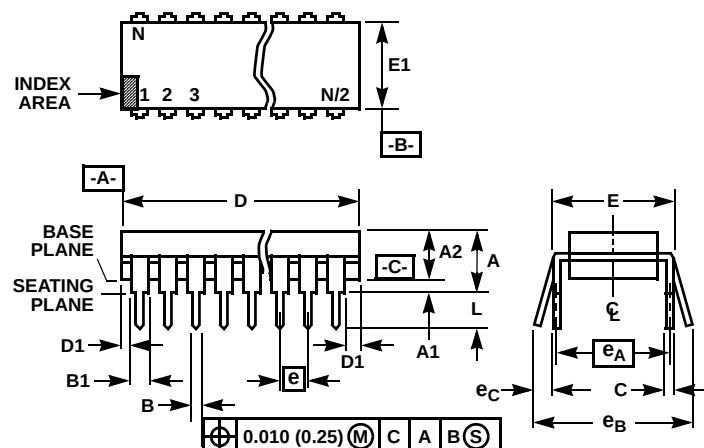
## F28.6 MIL-STD-1835 GDIP1-T28 (D-10, CONFIGURATION A) 28 LEAD CERAMIC DUAL-IN-LINE FRIT SEAL PACKAGE

| SYMBOL   | INCHES    |        | MILLIMETERS |       | NOTES |
|----------|-----------|--------|-------------|-------|-------|
|          | MIN       | MAX    | MIN         | MAX   |       |
| A        | -         | 0.232  | -           | 5.92  | -     |
| b        | 0.014     | 0.026  | 0.36        | 0.66  | 2     |
| b1       | 0.014     | 0.023  | 0.36        | 0.58  | 3     |
| b2       | 0.045     | 0.065  | 1.14        | 1.65  | -     |
| b3       | 0.023     | 0.045  | 0.58        | 1.14  | 4     |
| c        | 0.008     | 0.018  | 0.20        | 0.46  | 2     |
| c1       | 0.008     | 0.015  | 0.20        | 0.38  | 3     |
| D        | -         | 1.490  | -           | 37.85 | 5     |
| E        | 0.500     | 0.610  | 12.70       | 15.49 | 5     |
| e        | 0.100 BSC |        | 2.54 BSC    |       | -     |
| eA       | 0.600 BSC |        | 15.24 BSC   |       | -     |
| eA/2     | 0.300 BSC |        | 7.62 BSC    |       | -     |
| L        | 0.125     | 0.200  | 3.18        | 5.08  | -     |
| Q        | 0.015     | 0.060  | 0.38        | 1.52  | 6     |
| S1       | 0.005     | -      | 0.13        | -     | 7     |
| $\alpha$ | 90°       | 105°   | 90°         | 105°  | -     |
| aaa      | -         | 0.015  | -           | 0.38  | -     |
| bbb      | -         | 0.030  | -           | 0.76  | -     |
| ccc      | -         | 0.010  | -           | 0.25  | -     |
| M        | -         | 0.0015 | -           | 0.038 | 2, 3  |
| N        | 28        |        | 28          |       | 8     |

Rev. 0 4/94



# Dual-In-Line Plastic Packages (PDIP)



## NOTES:

1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
4. Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
6. E and  $e_A$  are measured with the leads constrained to be perpendicular to datum  $-C-$ .
7.  $e_B$  and  $e_C$  are measured at the lead tips with the leads unconstrained.  $e_C$  must be zero or greater.
8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
9. N is the maximum number of terminal positions.
10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

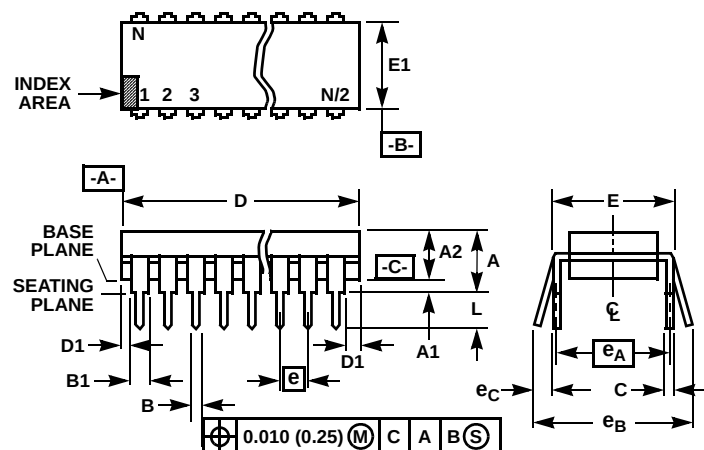
## E28.6 (JEDEC MS-011-AB ISSUE B) 28 LEAD DUAL-IN-LINE PLASTIC PACKAGE

| SYMBOL | INCHES    |       | MILLIMETERS |       | NOTES |
|--------|-----------|-------|-------------|-------|-------|
|        | MIN       | MAX   | MIN         | MAX   |       |
| A      | -         | 0.250 | -           | 6.35  | 4     |
| A1     | 0.015     | -     | 0.39        | -     | 4     |
| A2     | 0.125     | 0.195 | 3.18        | 4.95  | -     |
| B      | 0.014     | 0.022 | 0.356       | 0.558 | -     |
| B1     | 0.030     | 0.070 | 0.77        | 1.77  | 8     |
| C      | 0.008     | 0.015 | 0.204       | 0.381 | -     |
| D      | 1.380     | 1.565 | 35.1        | 39.7  | 5     |
| D1     | 0.005     | -     | 0.13        | -     | 5     |
| E      | 0.600     | 0.625 | 15.24       | 15.87 | 6     |
| E1     | 0.485     | 0.580 | 12.32       | 14.73 | 5     |
| e      | 0.100 BSC |       | 2.54 BSC    |       | -     |
| $e_A$  | 0.600 BSC |       | 15.24 BSC   |       | 6     |
| $e_B$  | -         | 0.700 | -           | 17.78 | 7     |
| L      | 0.115     | 0.200 | 2.93        | 5.08  | 4     |
| N      | 28        |       | 28          |       | 9     |

Rev. 1 12/00



# Dual-In-Line Plastic Packages (PDIP)



## NOTES:

1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
4. Dimensions A, A1 and L are measured with the package seated in JEDEC seating plane gauge GS-3.
5. D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
6. E and eA are measured with the leads constrained to be perpendicular to datum -C-.
7. eB and eC are measured at the lead tips with the leads unconstrained. eC must be zero or greater.
8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
9. N is the maximum number of terminal positions.
10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 - 0.045 inch (0.76 - 1.14mm).

## E18.3A (JEDEC MS-001-AC ISSUE D) 18 LEAD DUAL-IN-LINE PLASTIC PACKAGE

| SYMBOL | INCHES    |       | MILLIMETERS |       | NOTES |
|--------|-----------|-------|-------------|-------|-------|
|        | MIN       | MAX   | MIN         | MAX   |       |
| A      | -         | 0.210 | -           | 5.33  | 4     |
| A1     | 0.015     | -     | 0.39        | -     | 4     |
| A2     | 0.115     | 0.195 | 2.93        | 4.95  | -     |
| B      | 0.014     | 0.022 | 0.356       | 0.558 | -     |
| B1     | 0.045     | 0.070 | 1.15        | 1.77  | 8, 10 |
| C      | 0.008     | 0.014 | 0.204       | 0.355 | -     |
| D      | 0.880     | 0.920 | 33.27       | 34.65 | 5     |
| D1     | 0.005     | -     | 0.13        | -     | 5     |
| E      | 0.300     | 0.325 | 7.62        | 8.25  | 6     |
| E1     | 0.240     | 0.280 | 6.10        | 7.11  | 5     |
| e      | 0.100 BSC |       | 2.54 BSC    |       | -     |
| eA     | 0.300 BSC |       | 7.62 BSC    |       | 6     |
| eB     | -         | 0.430 | -           | 10.92 | 7     |
| L      | 0.115     | 0.150 | 2.93        | 3.81  | 4     |
| N      | 18        |       | 18          |       | 9     |

Rev. 0 5/00

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